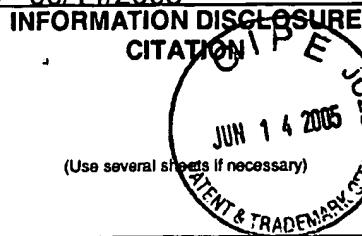


IDS - 06/14/2005



ATTY. DOCKET NO. 829-620 SERIAL NO. 10/771,263
 APPLICANT SHIMADA et al
 FILING DATE February 4, 2004 GROUP 2871

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

				TRANSLATION			
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
TC	0 486 047	5-1992	EP				
TC	6-346025 A	12-1994	JP			partial	

OTHER DOCUMENTS (including Author, Title, Date, Pertinent pages, etc.)

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TC	M.W. Friends, Determination of Dielectric Constant for Fuji Clear, Mar. 7, 1996, pp:15-2, including Table.
TC	Willem den Boer, A Two5-Diode Pixel Circuit and Addressing Method for MIM LCDs, OIS Optical Systems, Inc., Northville, MI, USA.
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TC	Decision on Appeal mailed October 12, 2001 in corresponding JP application No. 10-220219 (JP Patent No. 3247870)
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TC	European Search Report mailed June 4, 2004 in corresponding EP application 02017257.3

*Examiner /Tarifur Chowdhury/ (01/16/2007) Date Considered 01/16/2007

Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to application.